Electromagnetic Sub-wavelength Imaging Using The Basis Matrix Method In Conjunction with Singular Value Decomposition (SVD) Algorithm

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Abstract—In this work, we employ a novel basis matrix method, applied in conjunction with the singular value decomposition (SVD) algorithm to achieve sub-wavelength resolution in the images derived by using phase conjugation (PC) scheme in the microwave imaging problem. Illuminative examples of different bar-code type of distributions are presented, together with the images recovered by using the proposed method.

Keywords: microwave imaging, phase conjugation (PC), sub-wavelength resolution, singular value decomposition (SVD), basis matrix method.

I. INTRODUCTION

Recently, the topics of phase conjugation (PC) [1] as well as time-reversal mirrors (TRM) [2] have been investigated in the context of microwave imaging. A number of papers that deal with the methods based on far-field measurements have been reported in the literature, including: those that employ metallic strip gratings which perform evanescent-to-propagating wave conversion [3]; and split-ring resonators loaded with varactor diodes [4]. The resolution capability of a phase conjugating lens has also been studied in [5]-[6]. In this work, we propose a basis matrix method applied in conjunction with the singular value decomposition (SVD) to achieve a sub-wavelength level of resolution in the context of microwave imaging problem using phase conjugation lens. We described the proposed method in detail and examined its abilities to resolve at the sub-wavelength level.

II. IMAGING ALGORITHMS

A. Phase Conjugation

Figure 1 shows a representative scheme for 3D phase conjugation lens imaging system. The test objects are perfect electric conductor (PEC) squares that are distributed in the source plane \( f(x,y)@z=0 \), and are illuminated by an incident plane wave. At the measurement plane \( g(x,y)@z=d \), the phase conjugation lens collects the scattered field, phase conjugates this field and propagates it to the image plane \( h(x,y)@z=2d \) to form the image.

For the purpose of our simulation, we mimic the phase conjugating operation of the lens, applied to the measured field, on the computer. Let us assume that we are working with the \( E_y \)-component of the electric field. Then, the steps involved in the phase conjugation procedure can be summarized as follows: (i) measure the \( E_y \)-component of the scattered electric field from the PEC squares at the measurement plane, which is located at \( z=d \); (ii) phase conjugate and Fourier transform the spatial distribution to the wavenumber domain; (iii) propagate the spectral distribution to the image plane at \( z=2d \); (iv) inverse-Fourier transform the spectral distribution at \( z=2d \) to obtain the image.

Fig. 1. Schematic for 3D imaging via basis matrix method.

Note that in the proposed method we only need to deal with the data sampled in the image plane to improve the resolution of the image. This, in turn, results in considerable saving in terms of data collection and processing, in comparison to that needed if we’re to collect the data directly in the measurement plane. Note also that the phase
B. Basis Matrix Method with Singular Value Decomposition

Next, we describe an imaging algorithm based on the basis matrix method. As a starter, we use a MoM code (FEKO) to simulate the case of a single PEC square at a time, which is located in the object plane. We derive the scattered field distribution in the measurement plane, phase conjugate it, and then let it propagate to the image plane. Finally, we extract a part of the image distribution, for instance its values along the y=0 cut to form a column of the basis matrix. The number of the columns in this matrix corresponds to the number of possible positions for the PEC square in the source plane. We apply the singular value decomposition algorithm to the basis matrix, and use a threshold to delete the singular vectors, whose singular value fall below the threshold.

III. NUMERICAL RESULTS

Figure 1 shows a representative scheme 3D imaging by using the proposed method. The size of the PEC square is 0.05λ*0.05λ, and the spacing is 0.25λ in both x- and y-directions. The distance between the source and measurement planes is 3λ. The size of the measurement aperture is 30λ*30λ with 0.05λ interval in both x- and y-directions. And the size of the image zone is 10λ*10λ with 0.25λ interval in both x- and y-directions. The operating frequency is 1GHz, and the plane wave is normally incident. Fig. 2 shows the imaging models for the 1D and 2D cases. The basis matrices are comprised of 13 and 39 columns, respectively. The object zone in the x-direction ranges from -1.5λ to 1.5λ.

Fig. 2. Imaging models for (a) 1D case (x-direction); and (b) 2D case (x-y plane).

Figures 3 and 4 show the recovered results for the 1D and 2D cases, respectively, the stars and the bars represent the original and the recovered positions of PEC squares, respectively. The horizontal line at the level of 0.5 (normalized) is used to distinguish the real objects from the false ones. Here, we have set a threshold of 10^{-5} for the truncation of the singular values. For the 1D case, we only extract y=0 cut to generate the basis matrix, and find 13 singular vectors survive. For the 2D case, we use three cuts e.g., at y=-0.1λ, 0λ, 0.1λ, and 35 singular vectors are survived. From Figs. 3 and 4, we see that the basis matrix method, applied in conjunction with the SVD is capable of accurately recovering the position of the object systematically investigated the noise.

Fig. 3. Imaging results for the 1D case (x-direction) via the basis matrix method.

Fig. 4. Imaging results for the 2D case (x-y plane) via the basis matrix method.

We have considered the noise issue, and have also studied the 2D case in the x-z plane, i.e., objects with depth information. These results will be included in the presentation.

References